Electronics Systems

Lesson #3
Chapter 1
Conversion from Analog to Digital

- This an example of sampling with 8 regions or zones
- There are 3 bits per sample
- The zones are $\Delta$ units wide
Digital to Analog Reconstruction

- This an example of the reconstruction of the original signal from the coded samples
- This line is the staircase approximation of the samples from the codes
- This line is the approximation as a result of the applying a low pass filter to the staircase approximation
- Note the quantization error/noise
Analog vs Digital

• Noise
  – Analog signals are prone to noise
  – Noise is less damaging to Digital signals since we know what values the digital signal takes on

• Circuitry
  – Digital signals can be easily processed by electronic circuits or Integrated Circuits – ICs
  – Analog signals require filters and other elements to assure that the signal is not distorted

• Transmission
  – More digital information can be transmitted than analog information over the same transmission lines.
Design Process

• System Design
  – Initial Development
    • Ideas from Customer Needs
    • Develop Specs from Customer Needs
    • Invent Possible Solutions to meet the Specs
    • Design System Block Diagrams of the Preferred Solution
  – Development of Prototypes
    • Based on the Preferred Solution, a preliminary breadboard circuit design is made and tested
    • If breadboard design meets the Specs, then a prototype circuit is made and tested
    • If the prototype meets the Specs, then Production can begin
  – Production
    • Continual testing against the Spec are made to assure System Quality
Design Process

• Circuit Design
  – Develop a Circuit Configuration
  – Select Component Values
  – Estimate Performance
  – Construct Prototype
  – Test
  – Document
Integrated Circuits

• Building many circuits to fit into small packages
• The process to build ICs is based on technologies used to manufacture the transistor
**Metal Oxide Semiconductor Field Effect Transistor**

**MOSFET (NMOS) Enhancement Mode**

- Consists of Four terminals
  - Drain which is $n$-doped material
  - Source also $n$-doped material
  - Base which is $p$-doped material
  - Gate is a metal and is insulated from the Drain, Source and Base by a thin layer of silicon dioxide ~ .05-.1 mm thick

- Basically, an electric current flowing from drain to source, $i_D$, is controlled by the amount of voltage (electric field) appearing between the gate and base (note that the base and source are usually tied together and therefore, it is referred to as the gate to source voltage or gate voltage), $v_{GS}$.

- $i_D$ flows through a channel of $n$-type material which is induced by $v_{GS}$. The amount of $i_D$ is a function of the thickness of the channel and the voltage between drain and source, $v_{DS}$.

- However, the thickness of channel is controlled by the level of gate voltage. (The width, .5 to 500 mm, and length, .2 to 10 mm, of the channel is shown in the diagram.)
IC Fabrication

\[ \text{SiO}_2 \quad n\text{-type Substrate} \]

\[ \text{Photo Resist} \quad \text{MASK} \quad \text{Light} \]
IC Fabrication

$SiO_2$ $\rightarrow$ 

$p$-type Substrate

$n$-type Substrate

$p$-type Atoms

Photo Resist
IC Fabrication

- n-type Substrate
- Photo Resist
- SiO$_2$
- MASK
- Light
- p-type Substrate

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IC Fabrication

SiO$_2$ → $n$-type Substrate → $n$-type Atoms

Photo Resist → $p$-type Substrate → $n$-type Substrate
IC Fabrication

- n-type Substrate
- p-type Substrate
- n-type Substrate

Contacts
**Basic Amplifier Types**

- An amplifier produces an output signal with the same wave shape as the input signal but usually with a larger amplitude.
  
  \[ v_o(t) = A_v v_i(t) \]

- \( A_v \) is called the voltage gain and if <0 then the amplifier is inverting; otherwise non-inverting.
Voltage-Amplifier Model

- Parameters:
  - Open Circuit Voltage Gain $A_{vo}$
  - Input and Output impedance $R_i = v_i / i_i; R_o = v_o / i_o$ (after removing $R_L$ and replacing all sources with their internal resistance)
  - Voltage Gain $A_v = v_o / v_i = A_{vo} R_L / (R_L + R_o) \neq A_{vo}$
  - Current Gain $A_i = i_o / i_i = (v_o / R_L) / (v_i / R_i) = A_v R_i / R_L$
  - Power Gain $G = P_o / P_i = v_o i_o / v_i i_i = A_v A_i = (A_v)^2 R_i / R_L$
Voltage-Amplifier Model

- System Parameters:
  - Voltage Gain $A_{vs} = \frac{v_o}{v_s} = A_{vo} \frac{R_L}{(R_L + R_o)R_i/(R_i + R_s)}$
    $\neq A_{vo} \neq Av$
  - Power Gain $G_s = P_o / P_s = \frac{v_o i_o}{v_s i_s} = A_{vs} A_i$
    $= (A_v)^2 \frac{R_i}{R_L} * \frac{R_i}{(R_i + R_s)}$
Example:
n_v = 10 \text{ mv}, R_s = 2M\Omega, R_L = 10\Omega

A_{vo} = 100, R_i = 2M\Omega, R_o = 5\Omega

\[ v_i = v_s \frac{R_i}{R_i + R_s} = 10m \frac{2M}{2M + 2M} = 5mV \]

\[ A_{vo}v_i = 100 \times 5m = .5V \]

\[ v_o = A_{vo}v_i \frac{R_L}{R_L + R_o} = .5 \times \frac{10}{10 + 5} = 0.33V \]

\[ A_v = \frac{v_o}{v_i} = 0.33 \frac{5m}{5m} = 66.7; A_{vs} = \frac{v_o}{v_s} = 0.33 \frac{10m}{10m} = 33.3 \]

\[ A_i = \frac{i_o}{i_i} = \frac{v_o/R_L}{v_i/R_i} = A_v \frac{R_i}{R_L} = 66.7 \times \frac{2M}{10} = 1.33 \times 10^7 \]

\[ G = 1.33 \times 10^7 \times 66.7 \times 8.9 \times 10^8; G_s = 1.33 \times 10^7 \times 33.3 \times 4.4 \times 10^8 \]

Note that \( A_v = 66.7 \) and \( A_{vo} = 100 \)

This difference is due to \( R_L \) and \( R_o \); that is the effects of the Load

Also \( A_{vs} = 33 \) which is due to \( R_o \) and \( R_i \)
Homework

• Probs
  – 1.15 repeat using a load resistance of 8 Ω and then a load resistance of 2 Ω; describe what happens and why – prove it for extra credit.
  – 1.17 Use input resistance = 100Ω, input voltage 10m V rms and output voltage 10 V rms
  – 1.18,
  – 1.19 use load resistor of 100k Ω and source resistor of 500k Ω